

**Notice of References Cited**

Application/Control No.

10/522,007

Applicant(s)/Patent Under  
Reexamination  
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Examiner

Michael Pervan

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0063671	05-2002	Knapp, Alan G.	345/87
*	B	US-7,136,040	11-2006	Park et al.	345/100
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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**NON-PATENT DOCUMENTS**

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